

<b>Notice of References Cited</b>	Application/Control No. 10/073,636	Applicant(s)/Patent Under Reexamination AVISON, BEN	
	Examiner Annan Q. Shang	Art Unit 2623	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,445,738	09-2002	Zdepski et al.	375/240.01
*	B	US-6,480,667	11-2002	O'Connor, Dennis M.	386/83
*	C	US-5,973,685	10-1999	Schaffa et al.	715/722
*	D	US-6,762,797	07-2004	Pelletier, Daniel	348/559
*	E	US-6,259,441	07-2001	Ahmad et al.	715/720
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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